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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/699,091	CHEN ET AL.	
Examiner	Art Unit	
Marc S. Zimmer	1712	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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(INCLUDING SE	ARCH STRATEGY	)
	DATE	EXMR
EAST	3/23/2005	MZ
inventor search	3/23/2005	MZ